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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/961,362	YANG ET AL.	
Examiner	Art Unit	
David C. Payne	2638	

SEARCHED			
Class	Subclass	Date	Examiner
700	19,20,59, 65	10/3/2005	DCP
398	106, 107	10/3/2005	DCP
398	25	4/2/05	sef
398	53,98	7/24/05	h
398	66,107		
385	14		
398	82	V	V
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
PLAUB T	XTSRCH	3/16/05	Dep	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
class/subclass as listed (text search only)	10/3/2005	DCP		
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